

SCHOTTKY DIODES KDN-02020.
PRELIMINARY



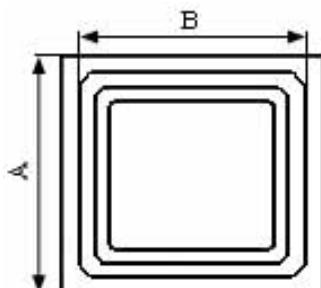
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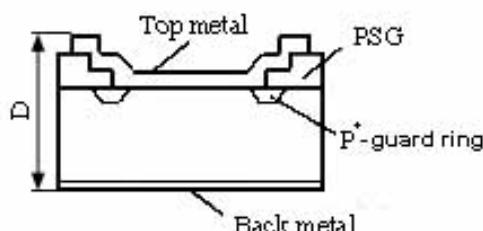
VSP-MIKRON

2A/20V. Die Size-45mil.

Electrical Characteristics	Symbol	Unit	Spec. limit	Die Sort
Breakdown Voltage @ $I_R=10\text{mA}$	V_{BR}	V	20	25
Average Rectified Forward Current	$I_{F(AV)}$	A	2,0	-
DC Forward Voltage @ 25°C , $I_F=2,0\text{A}$	V_F	V	0,48	0,45
Maximum Reverse Current @ 25°C , $V_R=25\text{V}$ 25°C , $V_R=20\text{V}$ 125°C , $V_R=20\text{V}$	I_R	mA	- 0,080 0,050 22,0	0,080 0,050 20,0
Peak Forward Surge Current 8,3ms single half sine-wave superimposed on rated load (JEDEC METHOD)	I_{FSM}	A	50	-
Peak Repetitive Reverse Surge Current @ $2,0\mu\text{s}$, $f=1\text{kHz.}$, $T_J<150^\circ\text{C.}$	I_{RRM}	A	1,5	
Electrostatic Discharge Voltage. JEDEC Method. ESD HBM. Contact.	ESD	kV	± 8 (contact)	
Voltage Rate of Change	dV/dt	V/ μS	10.000	
Operating Junction Temperature	T_J	°C	150	



DIM	ITEM	µm
A_x	Wafer Form Die Size	1150
A_y		1150
B_x	Top Metal Size	1010
B_y		1010
D	Thickness	300max.
Scribe line Width		80



Top metal: a) **Al** – for Wire Bonding;
b) **Al-Ni-Ag** – for Soldering.

Backside metal: **Ti-Ni-Ag**.